

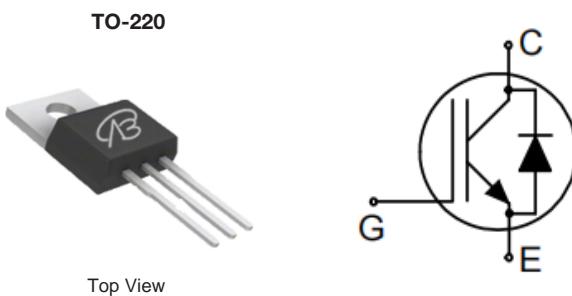
# VBM16I15 Datasheet

## 600V Trench and Fieldstop IGBT

PRODUCT SUMMARY		
$V_{CE}$ (V)		600
$I_C$ (A)	30 (TC=25 °C)	15 (TC=100 °C)
$V_{CE(\text{sat})}$ (V)		1.6
$Q_g$ (nC)		65
$I_{CM}$ (A)		45

### FEATURES

- Very Low  $V_{CE\text{sat}}$
- Low turn-off losses
- High speed switching
- Maximum junction temperature 175°C
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)



Top View

### APPLICATIONS

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing
  - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)

### Package pin definition

- Pin1 G - Gate
- Pin2 C & backside - Collector
- Pin3 E - Emitter

ABSOLUTE MAXIMUM RATINGS ( $T_C = 25$ °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Collector-Emitter Voltage	$V_{GE}$ at 15 V	$V_{CE}$	600	V
Gate-Emitter Voltage		$V_{GE}$	$\pm 30$	
Continuous Collector Current ( $T_J = 150$ °C)	$T_C = 25$ °C	$I_C$	30	A
	$T_C = 100$ °C		15	
Pulsed Collector Current <sup>a</sup>		$I_{CM}$	45	
Diode Forward Current <sup>b</sup>		$I_F$	60	A
Maximum Power Dissipation	$T_C = 25$ °C	$P_D$	170	W
	$T_C = 100$ °C		31	
Operating Junction and Storage Temperature Range		$T_J, T_{stg}$	-55 to +175	°C
Short Circuit Withstand Time $T_C=150$	$V_{GE} = 15V, V_{CE} = 400V$	tsc	3	μs
Short Circuit Withstand Time $T_C=100$	$V_{GE} = 15V, V_{CE} = 330V$		5	
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s		260	°C

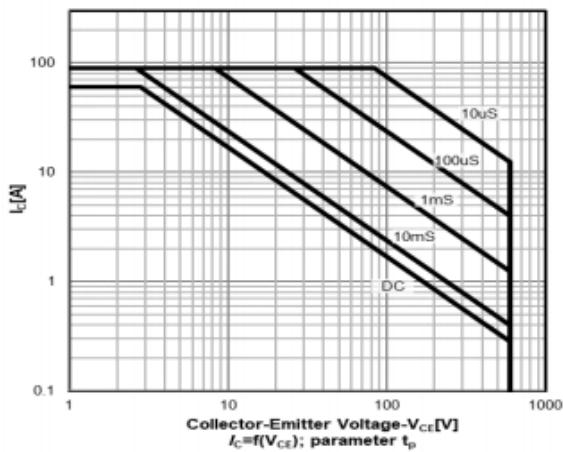
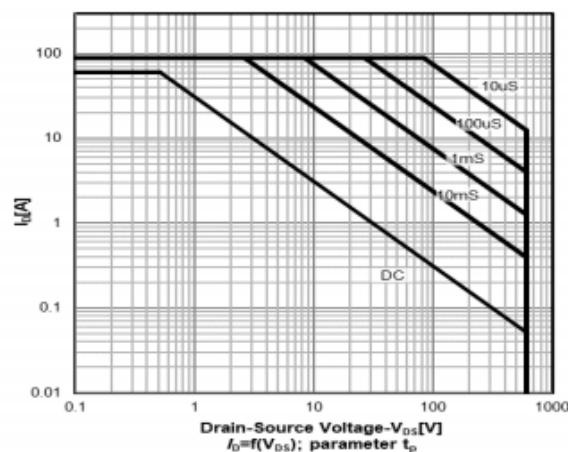
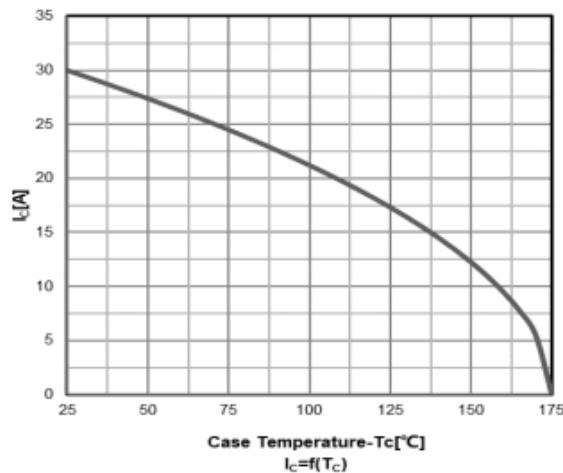
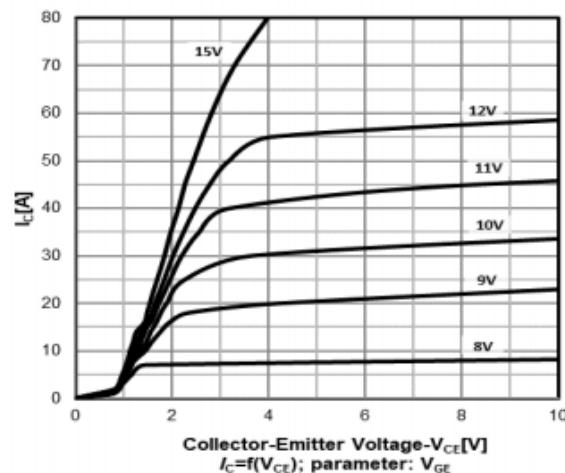
### Notes

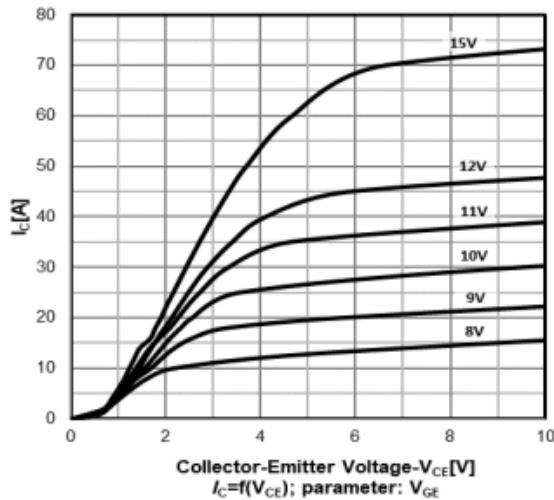
- Repetitive rating; pulse width limited by maximum junction temperature.
- Current limited by maximum junction temperature.
- 1.6 mm from case.

<b>THERMAL RESISTANCE RATINGS</b>				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	40	80	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Case	$R_{thJC}$	0.88	4.8	

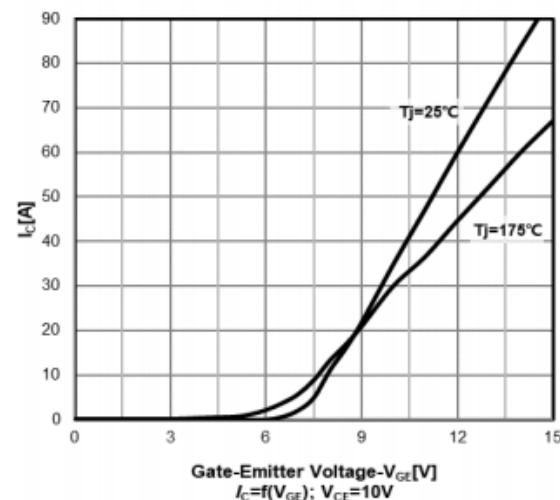
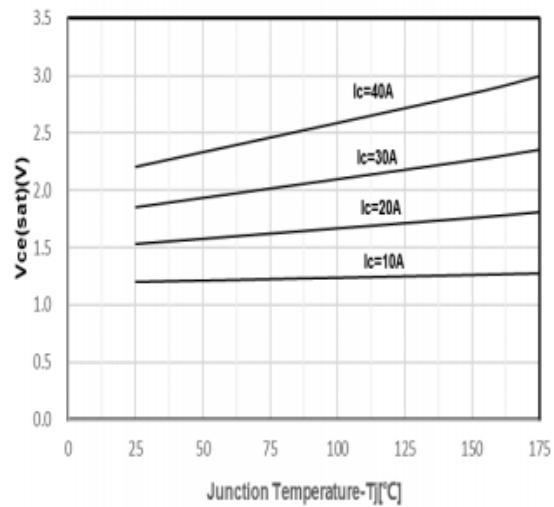
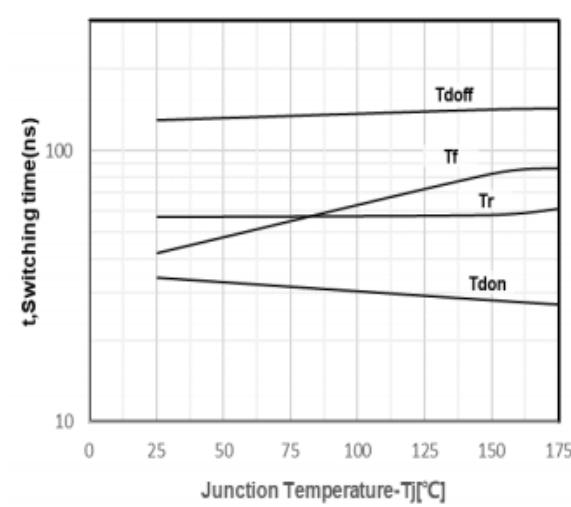
<b>SPECIFICATIONS</b> ( $T_J = 25^{\circ}\text{C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Collector-Emitter Breakdown Voltage	$\text{BV}_{\text{CE}}$	$\text{V}_{\text{GE}} = 0 \text{ V}$ , $I_C = 250 \mu\text{A}$	$\text{V}_{\text{GE}} = 0 \text{ V}$ , $I_C = 1 \text{ mA}$	600 600	- -	- -	V
Gate-Source Threshold Voltage (N)	$\text{V}_{\text{GE}(\text{th})}$	$\text{V}_{\text{CE}} = \text{V}_{\text{GE}}$ , $I_D = 250 \mu\text{A}$		4	5	6	V
Zero Gate Voltage Collector Current	$I_{\text{CES}}$	$\text{V}_{\text{CE}} = 480 \text{ V}$ , $\text{V}_{\text{GE}} = 0 \text{ V}$ , $T_J = 25^{\circ}\text{C}$	$\text{V}_{\text{CE}} = 480 \text{ V}$ , $\text{V}_{\text{GE}} = 0 \text{ V}$ , $T_J = 150^{\circ}\text{C}$	-	1	20	$\mu\text{A}$
Gate-Emitter Leakage Current	$I_{\text{GES}}$	$\text{V}_{\text{CE}} = 0 \text{ V}$ , $\text{V}_{\text{GS}} = \pm 2 \text{ V}$		-	-	100	nA
Collector-Emitter Saturation Voltage	$\text{V}_{\text{CE}(\text{sat})}$	$\text{V}_{\text{GE}} = 15 \text{ V}$	$I_C = 30 \text{ A}$	-	1.6	2.1	V
Forward Transconductance	$g_{\text{fs}}$	$\text{V}_{\text{CE}} = 20 \text{ V}$	$I_C = 30 \text{ A}$	-	16	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{\text{ies}}$	$\text{V}_{\text{GE}} = 0 \text{ V}$ , $\text{V}_{\text{CE}} = 25 \text{ V}$ , $f = 500 \text{ KHz}$		-	1800	-	pF
Output Capacitance	$C_{\text{oes}}$			-	82	-	
Reverse Transfer Capacitance	$C_{\text{res}}$			-	12	-	
Turn-on Energy	$E_{\text{on}}$	$\text{V}_{\text{CS}} = 400 \text{ V}$ , $\text{V}_{\text{GE}} = 0 / 15 \text{ V}$ , $I_C = 30 \text{ A}$ , $R_g = 10\Omega$		-	0.62	-	ns
Turn-off Energy	$E_{\text{off}}$			-	0.31	-	
Total Gate Charge	$Q_g$	$\text{V}_{\text{GE}} = 15 \text{ V}$	$I_C = 30 \text{ A}$ , $\text{V}_{\text{CE}} = 400 \text{ V}$	-	65	-	nC
Gate-Emitter Charge	$Q_{\text{ge}}$			-	14	-	
Gate to Collector Charge	$Q_{\text{gc}}$			-	13	-	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$\text{V}_{\text{CS}} = 400 \text{ V}$ , $\text{V}_{\text{GE}} = 0 / 15 \text{ V}$ , $I_C = 30 \text{ A}$ , $R_g = 10\Omega$		-	60	-	ns
Rise Time	$t_r$		-	43	-		
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	184	-		
Fall Time	$t_f$		-	30	-		
Internal emitter inductance measured 5 mm	$L_E$		-	13	-	nH	
<b>Diode Characteristics</b>							
Diode Forward Current	$I_F$	IGBT symbol showing the integral reverse junction diode		-	-	15	A
Pulsed Diode Forward Current	$I_{\text{FM}}$			-	-	45	
Diode Forward Voltage	$V_F$	$I_F = 30 \text{ A}$		-	1.35	2.0	V
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = 25^{\circ}\text{C}$ , $I_F = 30 \text{ A}$ , $dI_F/dt = 200 \text{ A}/\mu\text{s}$ , $V_R = 400 \text{ V}$		-	73	-	ns
Reverse Recovery Charge	$Q_{\text{rr}}$			-	45	-	$\mu\text{C}$
Reverse Recovery Current	$I_{\text{RRM}}$			-	13	-	A

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

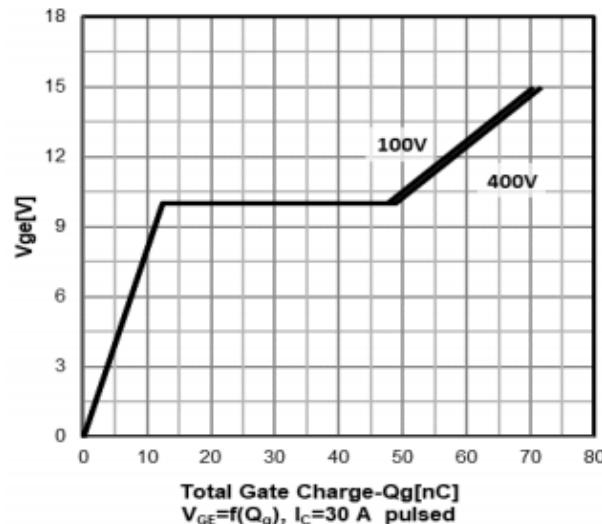
 Safe operating area Ta=25 °C  
 Non-Full PAK

 Safe operating area Ta=25 °C  
 Full PAK

 Collector current as a function of  
 Case temperature

 Typ. Output characteristics  
 $T_j=25$  °C


Typ. Output characteristics  
 $T_j=175\text{ }^\circ\text{C}$ 


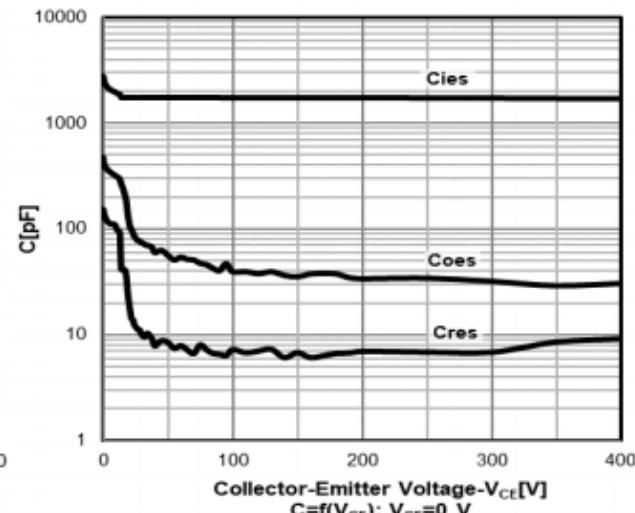
Typ. Transfer characteristics


 Typ. Collector-emitter saturation voltage as a function of junction temperature ( $V_{GE}=15\text{ V}$ )

 Typ. Switching times as a function of junction temperature (inductive load,  $V_{CE}=400\text{ V}$ ,  $V_{GE}=0/15\text{ V}$ ),  $R_g=10\Omega$ 


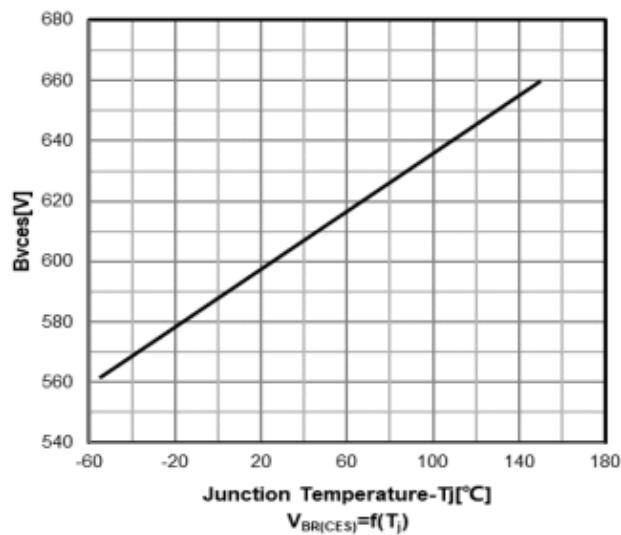
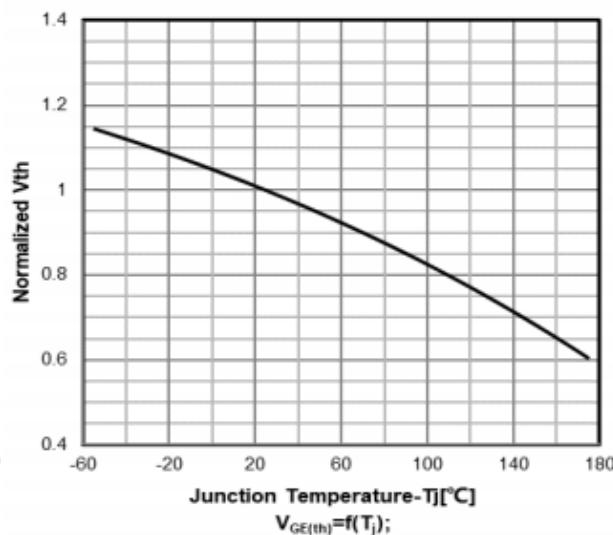
Gate charge characteristics



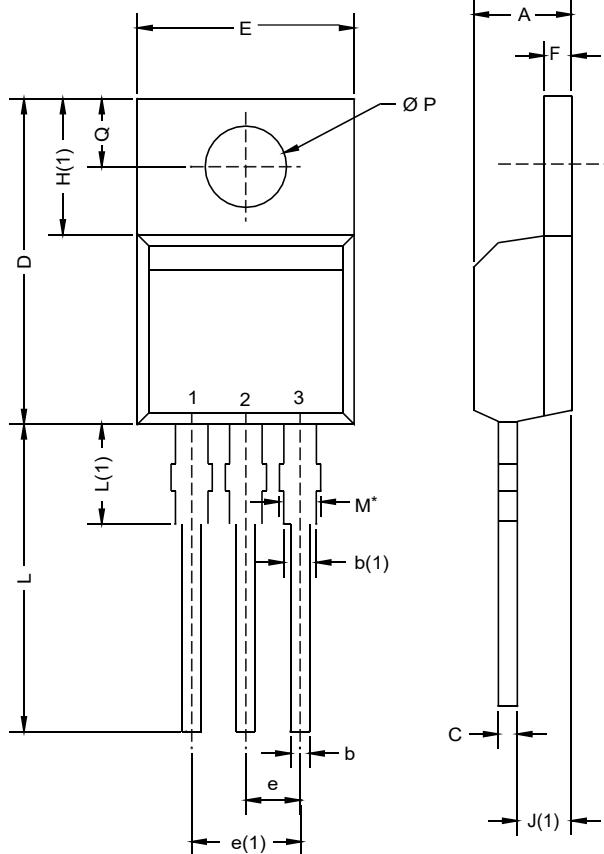
Capacitance characteristics



Collector-emitter breakdown voltage vs. temperature

Normalized  $V_{GE(th)}$  vs. temperature

## TO-220AB



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
c	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
E	10.04	10.51	0.395	0.414
e	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
Ø P	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118

ECN: X12-0208-Rev. N, DWG: 5471

### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion)  
 Heatsink hole for HVM

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